Unit: mm

TOSHIBA Infrared LED GaAs Infrared Emitter

TLN117(F)

Lead(Pb)-Free

Opto-Electoronic Switches

Floppy Disk Drives

Optical Mice

Optical Touch Sensors

- Small-side-view epoxy-resin package
- High radiant intensity: $I_E = 0.8 \text{mW} / \text{sr(min)}$ at $I_F = 20 \text{mA}$
- Half-angle value: $\theta 1 / 2 = \pm 15^{\circ} (typ.)$

Absolute Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit	
Forward current	IF	50	mA	
Pulse forward current	IFP	600 (Note 1)	mA	
Forward current derating (Ta > 25°C)	ΔI _F / °C	-0.33	mA / °C	
Reverse voltage	V _R	5	V	
Operating temperature	T _{opr}	-25~85	°C	
Storage temperature	T _{stg}	-40~100	°C	
Soldering temperature (5s)	T _{sol}	260 (Note 2)	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

(): Reference value

TOSHIBA

4-3P1

Weight: 0.1 g (typ.)

Pin Connection

1 ○ **★** ○ 2 1. Cathode 2 Anode

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Pulse width \leq 100 μ s, repetitive frequency =100Hz

Note 2: Soldering must be performed 2mm from the bottom of the package body.

Optical And Electrical Characteristics (Ta = 25°C)

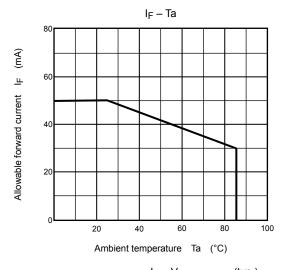
Characteristic	Symbol	Test Condition		Min	Тур.	Max	Unit
Forward voltage	V _F	I _F = 10mA		1.0	1.15	1.3	V
Reverse current	I _R	V _R = 5V		_	_	10	μA
Radiant intensity	ΙE	I _F = 20mA	TLN117(F)	8.0	_	_	mW / sr
			TLN117(B,F)	2	_	7.5	
			TLN117(C,F)	5	_	18.7	
Radiant power	PO	I _F = 20mA		_	2.5	_	mW
Capacitance	C _T	V _R = 0, f = 1MHz		_	30	_	pF
Peak emission wavelength	λ _P	I _F = 20mA		_	940	_	nm
Spectral line half width	Δλ	I _F = 20mA		_	50	_	nm
Half value angle	$\theta \frac{1}{2}$	I _F = 20mA		_	±15	_	٥

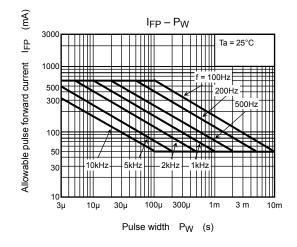
Precautions

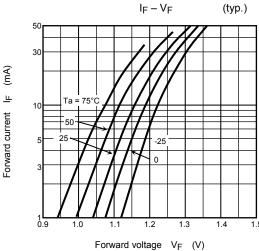
Please be careful of the followings.

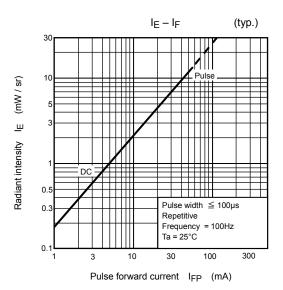
- 1. When forming the leads, bend each lead under the 2mm from the body of the device. Soldering must be performed after the leads have been formed.
- 2. Radiation intensity falls over time due to the current which flows in the infrared LED. When designing a circuit, take into account this change in radiant power over time. The ratio of fluctuation in radiation intensity to fluctuation in optical output is 1:1.

$$\frac{I_{E}(t)}{I_{E}(0)} = \frac{P_{O}(t)}{P_{O}(0)}$$

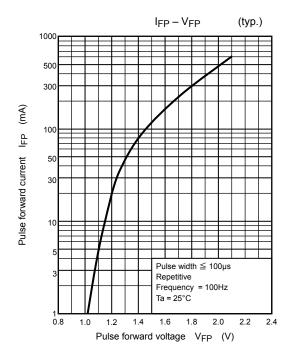


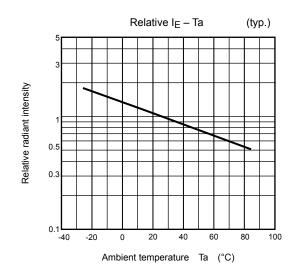


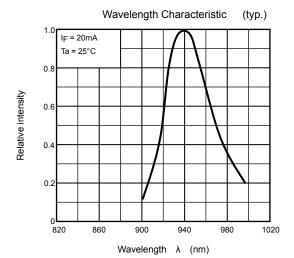


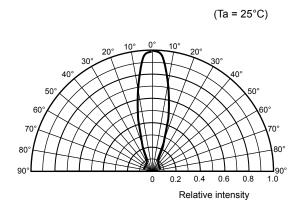


(typ.)









Radiation Pattern

RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No
 responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which
 may result from its use. No license is granted by implication or otherwise under any patents or other rights of
 TOSHIBA or the third parties.
- GaAs(Gallium Arsenide) is used in this product. The dust or vapor is harmful to the human body. Do not break, cut, crush or dissolve chemically.
- Please contact your sales representative for product-by-product details in this document regarding RoHS
 compatibility. Please use these products in this document in compliance with all applicable laws and regulations
 that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses
 occurring as a result of noncompliance with applicable laws and regulations.